

**Issue Classification**

Application/Control No.

10629020

Applicant(s)/Patent Under Reexamination

EZELL, R. WILLIAM

Examiner

Lee, Siu M

Art Unit

2611

## ORIGINAL

CLASS

SUBCLASS

375

316

## INTERNATIONAL CLASSIFICATION

CLAIMED

NON-CLAIMED

H

O

4

L

27 / 06 (2006.01.01)

## CROSS REFERENCE(S)

CLASS

SUBCLASS (ONE SUBCLASS PER BLOCK)

327

553

330

303

Lee, Siu M

8/3/2007

(Assistant Examiner)

(Date)

*Chieh M. Fan*

Total Claims Allowed:

20

(Legal Instruments  
Examiner)

(Date)

CHIEH M. FAN  
SUPERVISORY PATENT EXAMINER  
(Primary Examiner)

(Date)

8/3/07

O.G. Print Claim(s)

1

O.G. Print Figure

4